



# H12N60F

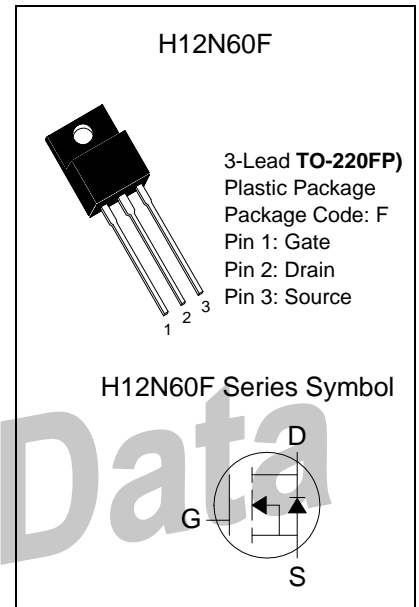
N-Channel Power MOSFET (600V,12A)

## Applications

- Switch Mode Power Supply
- Uninterruptable Power Supply
- High Speed Power Switching

## Features

- H10N60F is a High voltage NChannel enhancement mode power MOSFET chip fabricated in advanced silicon epitaxial planar technology
- Advanced termination scheme to provide enhanced voltageblocking capability
- Avalanche Energy Specified
- Source to Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode;
- The packaged product is widely used in AC-DC power suppliers, DCDC converters and Hbridge PWM motor drivers



## Absolute Maximum Ratings

Symbol	Parameter	Value		Units
$V_{DSS}$	Drain-Source Voltage	600		V
$I_D$	Continuous Drain Current ( $V_{GS}@10V, T_C=25^\circ C$ )	12		A
	Continuous Drain Current ( $V_{GS}@10V, T_C=100^\circ C$ )	7.6		A
$I_{DM}$	Pulsed Drain Current <sup>*1</sup>	40		A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$		V
$P_D$	Total Power Dissipation ( $T_C=25^\circ C$ )	TO-220AB	175	W
		TO-220FP	50	
	Linear Derating Factor	TO-220AB	1.43	W/ $^\circ C$
		TO-220FP	0.41	
$E_{AS}$	Single Pulse Avalanche Energy <sup>*2</sup>	68		mJ
$I_{AR}$	Avalanche Current <sup>*1</sup>	12		A
$E_{AR}$	Repetitive Avalanche Energy <sup>*1</sup>	66		mJ
$T_J$	Operating Junction Temperature Range	-55 to 150		$^\circ C$
$T_{stg}$	Storage Temperature Range	-55 to 150		$^\circ C$

\*1: Repetitive rating; pulse width limited by max. junction temperature

\*2: Starting  $T_J=25^\circ C, L=1.2mH, R_G=25\Omega, I_{AS}=10A$

\*3:  $I_{SD}\leq 14A, di/dt\leq 130A/us, V_{DD}\leq V_{(BR)DSS}, T_J\leq 150^\circ C$

## Thermal Characteristics

Symbol	Parameter	Value		Units
		TO-220AB	1.3	
$R_{\theta JC}$	Thermal Resistance Junction to Case (Max.)	TO-220FP	5	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Max.)	62		$^\circ C/W$



### Electrical Characteristics (T<sub>j</sub>=25°C, unless otherwise specified)

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	600	-	-	V
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	Reference to 25°C, I <sub>D</sub> =1mA	-	0.58	-	V/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V	-	-	10	uA
	Drain-Source Leakage Current	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V, T <sub>j</sub> =125°C	-	-	60	uA
I <sub>GSSF</sub>	Gate-Source Forward Leakage	V <sub>gsf</sub> =30V, V <sub>DS</sub> =0V	-	-	100	nA
I <sub>GSSR</sub>	Gate-Source Reverse Leakage	V <sub>gsr</sub> =-30V, V <sub>DS</sub> =0V	-	-	-100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2	-	4	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =6.0A <sup>*4</sup>	-	-	0.8	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =40V, I <sub>D</sub> =6.0A	-	5	-	S
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz	-	1830	-	pF
C <sub>oss</sub>	Output Capacitance		-	157	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	2.2	-	
t <sub>d(on)</sub>	Turn-on Delay Time	(V <sub>DD</sub> =325V, I <sub>D</sub> =12A, R <sub>G</sub> =4.7Ω, R <sub>D</sub> =32Ω) <sup>*4</sup>	-	50	-	ns
t <sub>r</sub>	Rise Time		-	50	-	
t <sub>d(off)</sub>	Turn-off Delay Time		-	311	-	
t <sub>f</sub>	Fall Time		-	55	-	
Q <sub>g</sub>	Total Gate Charge	(V <sub>DS</sub> =520V, I <sub>D</sub> =12A, V <sub>GS</sub> =10V) <sup>*4</sup>	-	52	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	10	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	19	-	

### Source-Drain Diode

Symbol	Characteristic		Min.	Typ.	Max.	Units
I <sub>S</sub>	Continuous Source Current (Body Diode)	Page1 MOSFET symbol showing the integral reverse P-N junction diode.	-	-	12	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =12A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C <sup>*4</sup>	-	-	1.4	V

\*4: Pulse Test: Pulse Width≤300us, Duty Cycle≤2%

\*5: C<sub>oss</sub> eff. Is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>



### TO-220AB Dimension

3-Lead TO-220AB  
Plastic Package  
HSMC Package Code: E

**Marking:**

Pb Free Mark  
Pb-Free: "●" (Note)  
Normal: None

Date Code      Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Gate 2 & Tab.Drain 3.Source

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

DIM	Min.	Max.
A	5.58	7.49
B	8.38	8.90
C	4.40	4.70
D	1.15	1.39
E	0.35	0.60
F	2.03	2.92
G	9.66	10.28
H	-	*16.25
I	-	*3.83
J	3.00	4.00
K	0.75	0.95
L	2.54	3.42
M	1.14	1.40
N	-	*2.54
O	12.70	14.27
P	14.48	15.87

\*: Typical, Unit: mm

### TO-220FP Dimension

3-Lead TO-220FP  
Plastic Package  
HSMC Package Code: F

**Marking:**

Pb Free Mark  
Pb-Free: "●" (Note)  
Normal: None

Date Code      Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Gate 2.Drain 3.Source

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

DIM	Min.	Max.
A	6.48	7.40
C	4.40	4.90
D	2.34	3.00
E	0.45	0.80
F	9.80	10.36
G	3.10	3.60
I	2.70	3.43
J	0.60	1.00
K	2.34	2.74
L	12.48	13.60
M	15.67	16.20
N	0.90	1.47
O	2.00	2.96
$\alpha 1/2/4/5$	-	*5°

Unit: mm

#### Important Notice:

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of HSMC.
- HSMC reserves the right to make changes to its products without notice.
- **HSMC semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- HSMC assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.

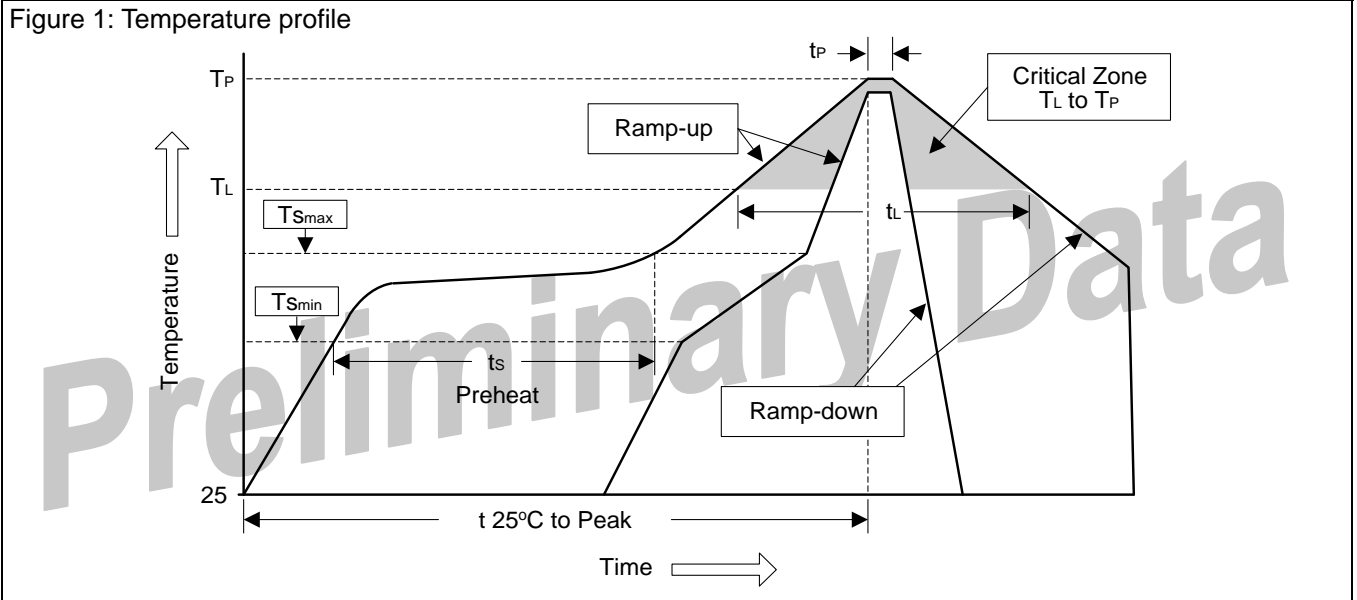
#### Head Office And Factory:

• **Head Office** (Hi-Sincerity Microelectronics Corp.): 10F.,No. 61, Sec. 2, Chung-Shan N. Rd. Taipei Taiwan R.O.C.  
 Tel: 886-2-25212056 Fax: 886-2-25632712, 25368454



## Soldering Methods for HSMC's Products

1. Storage environment: Temperature=10°C~35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (T <sub>Smin</sub> )	100°C	150°C
- Temperature Max (T <sub>Smax</sub> )	150°C	200°C
- Time (min to max) (ts)	60~120 sec	60~180 sec
T <sub>Smax</sub> to T <sub>L</sub>		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60~150 sec	60~150 sec
Peak Temperature (T <sub>P</sub> )	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t <sub>P</sub> )	10~30 sec	20~40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

### 3. Flow (wave) soldering (solder dipping)

Products	Peak temperature	Dipping time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec